

Application/Control No. 10/754,550	Applicant(s)/Patent unde Reexamination CHO, JANG-HO
Examiner	Art Unit
Benjamin P. Geib	2181

	ORIGI	NAL	INTERNATIONAL CLASSIFICATION											
	CLASS	SUBC	LASS	AIMED	N <sup>2</sup>				ON-CLAIMED					
	712	20	205		06	F	9	/30	G	06	F	9	/30	
	CROSS REF	ERENCES		1									,	
CLASS	SUBCLASS (O	NE SUBCLASS PE	R BLOCK)	<u> </u>	<u></u>			, 	1	ļ			<u> </u>	
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	min P. Geib 4/ stant Examiner)	(Data)	JJ	, s	ARKS	-	Total Claims Allowed: 21							
(71331		SU	PERVISC (Primary				<b>(AMINE</b> (Date)	<del>                                      </del>	O.G. Print Claim(s)					

	laims	ms renumbered in the same order as presented by applicant								□СРА			☐ T.D.			☐ R.1.47			
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121			151			181
2	2			32			62	]		92			122			152			182
3	3			33			63	]		93			123			153			183
4	4			34			64			94			124			154			184
5	5	]		35			65	j		95			125			155			185
6	6			36	]		66	j	<u> </u>	96			126	i		156			186
7	7			37	]		_67			97			127			157			187
8	8			38			68			98			128			158			188
9	9			39			69			99			129			159			189
10	10	]	_	40	]		70			100			130			160			190
11	11	]		41			71			101			131			161			191
12	12	]·		42			72			102			132			162			192
13	13	]		43			73			103			133			163			193
14	14			44	]		74	].		104			134			164			194
15	15			45			75			105			135			165			195
16	16			46	]		76			106			136			166			196
17	17			47	]		77	]		107			137			167			197
18	18			48			78	]		108			138			168			198
19	19	}		49	}		79			109			139			169			199
20	20			50	]		80	]		110			140			170			200
21	21			51	]		81			111			141			171			201
	22			52	] .		82	]		112			142			172			202
	23			53	]		83			113			143			173			203
	24	]		54			84			114			144			174			204
	25			55	]		85			115			145			175			205
	26	]		56	]		86			116			146			176			206
	27	]		57	]		87			117			147			177			207
	28	]		58			88	]		118			148			178			208
	29	]		59			89	]		119			149			179			209
	30			60			90	]		120			150			180			210

(Legal Instruments Examiner)

(Date)